

<b>Notice of References Cited</b>	Application/Control No. 10/606,860	Applicant(s)/Patent Under Reexamination SUN, WEIN-TOWN	
	Examiner RICARDO L. OSORIO	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,724,363	04-2004	Satoh et al.	345/100
*	B	US-5,751,186	05-1998	Nakao, Tomoaki	327/562
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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